

MOS FIELD EFFECT TRANSISTOR

2SK3430

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3430 is N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Super low on-state resistance:
- \bigstar RDS(on)1 = 7.3 m Ω MAX. (VGS = 10 V, ID = 40 A)
- ★ RDS(on)2 = 15 m Ω MAX. (VGS = 4 V, ID = 40 A)
- ★ Low Ciss: Ciss = 2800 pF TYP.
 - Built-in gate protection diode

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

	Drain to Source Voltage	VDSS	40	V
	Gate to Source Voltage	Vgss	±20	V
	Drain Current (DC)	I _{D(DC)}	±80	Α
	Drain Current (pulse) Note1	ID(pulse)	±200	Α
	Total Power Dissipation (Tc = 25°C)	Рт	84	W
	Total Power Dissipation (T _A = 25°C)	Рт	1.5	W
	Channel Temperature	T_{ch}	150	°C
	Storage Temperature	T_{stg}	-55 to +150	°C
*	Single Avalanche Current Note2	las	37	Α
*	Single Avalanche Energy Note2	Eas	137	mJ

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1 %

2. Starting T_{ch} = 25 °C, R_G = 25 Ω , V_{GS} = 20 V \rightarrow 0 V

ORDERING INFORMATION

PART NUMBER	PACKAGE		
2SK3430	TO-220AB		
2SK3430-S	TO-262		
2SK3430-Z	TO-220SMD		

(TO-220AB)



(TO-262)



(TO-220SMD)



THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	1.49	°C/W
Channel to Ambient	Rth(ch-A)	83.3	°C/W

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version. Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

Document No. Date Published Printed in Japan D14599EJ1V0DS00 (1st edition) March 2000 NS CP(K) The mark ★ shows major revised points.

© NEC Corporation 1999,2000

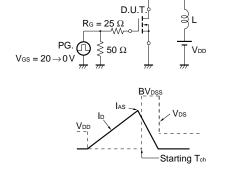


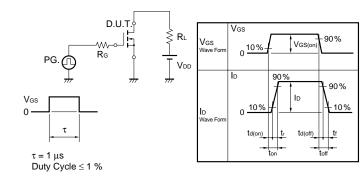
ELECTRICAL CHARACTERISTICS (TA = 25 °C)

	CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
*	Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, Ip = 40 A		5.9	7.3	mΩ
*		RDS(on)2	Vgs = 4 V, Ip = 40 A		10.5	15	mΩ
	Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	V
	Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 40 A	20	40		S
	Drain Leakage Current	Ioss	V _{DS} = 40 V, V _{GS} = 0 V			10	μΑ
	Gate to Source Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
*	Input Capacitance	Ciss	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		2800		pF
	Output Capacitance	Coss			730		pF
*	Reverse Transfer Capacitance	Crss			320		pF
*	Turn-on Delay Time	td(on)	$I_D = 40 \text{ A}, V_{GS(on)} = 10 \text{ V}, V_{DD} = 20 \text{ V},$		110		ns
*	Rise Time	tr	$R_G = 10 \Omega$		1800		ns
*	Turn-off Delay Time	td(off)			170		ns
*	Fall Time	tr			350		ns
	Total Gate Charge	Q _G	ID = 80 A , VDD = 32 V, VGS = 10 V		50		nC
*	Gate to Source Charge	Qgs			10		nC
*	Gate to Drain Charge	Q GD			14		nC
	Body Diode Forward Voltage	V _{F(S-D)}	IF = 80 A, VGS = 0 V		1.0		V
*	Reverse Recovery Time	trr	IF = 80 A, VGS = 0 V,		50		ns
*	Reverse Recovery Charge	Qrr	$di/dt = 100 A/\mu s$		77		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

TEST CIRCUIT 2 SWITCHING TIME

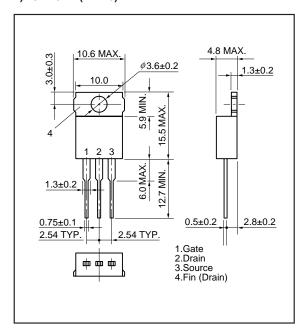




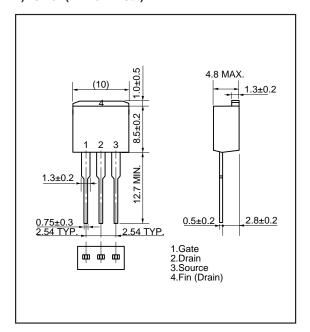
TEST CIRCUIT 3 GATE CHARGE

PACKAGE DRAWINGS (Unit: mm)

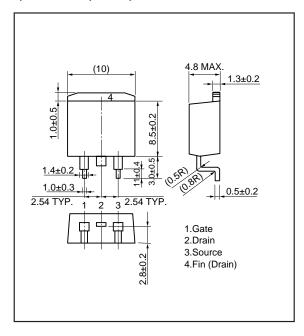
1) TO-220AB (MP-25)



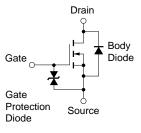
2) TO-262 (MP-25 Fin Cut)



3) TO-220SMD (MP-25Z)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

- The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version.
- No part of this document may be copied or reproduced in any form or by any means without the prior written
 consent of NEC Corporation. NEC Corporation assumes no responsibility for any errors which may appear in
 this document.
- NEC Corporation does not assume any liability for infringement of patents, copyrights or other intellectual property
 rights of third parties by or arising from use of a device described herein or any other liability arising from use
 of such device. No license, either express, implied or otherwise, is granted under any patents, copyrights or other
 intellectual property rights of NEC Corporation or others.
- Descriptions of circuits, software, and other related information in this document are provided for illustrative purposes in semiconductor product operation and application examples. The incorporation of these circuits, software, and information in the design of the customer's equipment shall be done under the full responsibility of the customer. NEC Corporation assumes no responsibility for any losses incurred by the customer or third parties arising from the use of these circuits, software, and information.
- While NEC Corporation has been making continuous effort to enhance the reliability of its semiconductor devices, the possibility of defects cannot be eliminated entirely. To minimize risks of damage or injury to persons or property arising from a defect in an NEC semiconductor device, customers must incorporate sufficient safety measures in its design, such as redundancy, fire-containment, and anti-failure features.
- NEC devices are classified into the following three quality grades:
 - "Standard", "Special", and "Specific". The Specific quality grade applies only to devices developed based on a customer designated "quality assurance program" for a specific application. The recommended applications of a device depend on its quality grade, as indicated below. Customers must check the quality grade of each device before using it in a particular application.
 - Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots
 - Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)
 - Specific: Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

The quality grade of NEC devices is "Standard" unless otherwise specified in NEC's Data Sheets or Data Books. If customers intend to use NEC devices for applications other than those specified for Standard quality grade, they should contact an NEC sales representative in advance.

M7 98.8